Lecture 12 Digital Circuits (II) MOS INVERTER CIRCUITS

Outline

- NMOS inverter with resistor pull-up
 - The inverter
- NMOS inverter with current-source pull-up
- Complementary MOS (CMOS) inverter
- Static analysis of CMOS inverter

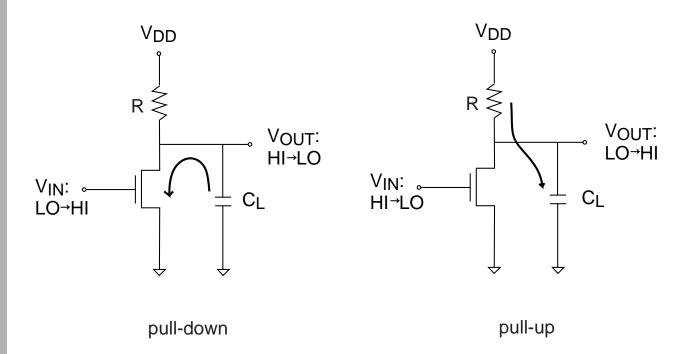
Reading Assignment:

Howe and Sodini; Chapter 5, Section 5.4

1. NMOS inverter with resistor pull-up:

Dynamics

- C_L *pull-down* limited by current through transistor
 - [shall study this issue in detail with CMOS]
- $C_L pull-up$ limited by resistor $(t_{PLH} \approx RC_L)$
- Pull-up slowest



1. NMOS inverter with resistor pull-up:

Inverter design issues

Noise margins $\uparrow \Rightarrow |A_v| \uparrow \Rightarrow$

- $R \uparrow \Rightarrow |RC_L| \uparrow \Rightarrow \text{slow switching}$
- $g_m \uparrow \Rightarrow |W| \uparrow \Rightarrow big transistor$
 - (slow switching at input)

Trade-off between speed and noise margin.

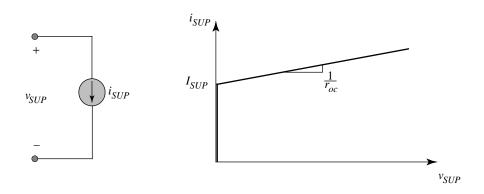
During pull-up we need:

- High current for fast switching
- But also high incremental resistance for high noise margin.

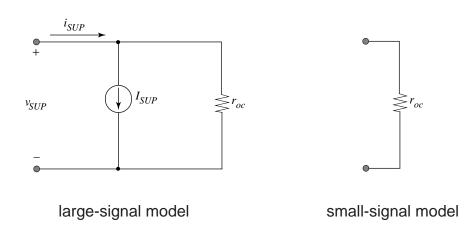
⇒ use *current source* as pull-up

2. NMOS inverter with current-source pull-up

I—V characteristics of current source:



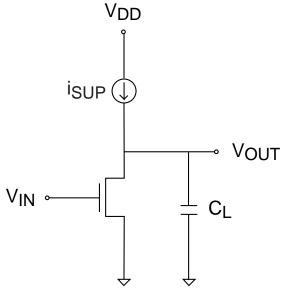
Equivalent circuit models:



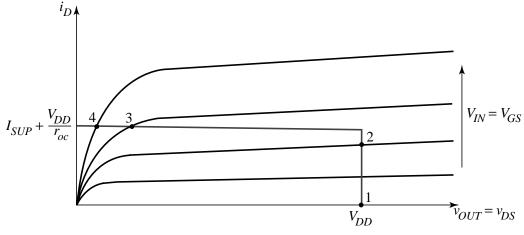
- High current throughout voltage range $v_{SUP} > 0$
- $i_{SUP} = 0$ for $v_{SUP} \le 0$
- $i_{SUP} = I_{SUP} + v_{SUP} / r_{oc} \text{ for } v_{SUP} > 0$
- High small-signal resistance r_{oc.}

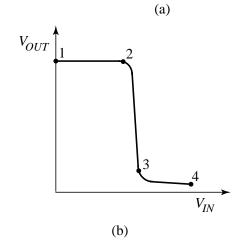
NMOS inverter with current-source pull-up

Static Characteristics



Inverter characteristics:

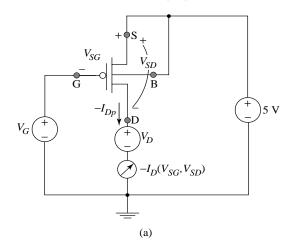


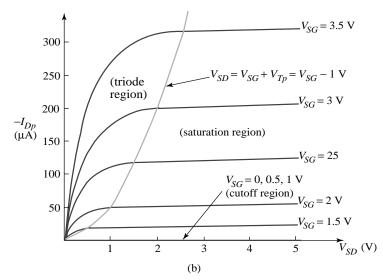


High $r_{oc} \Rightarrow$ high noise margins

PMOS as current-source pull-up

I—V characteristics of PMOS:





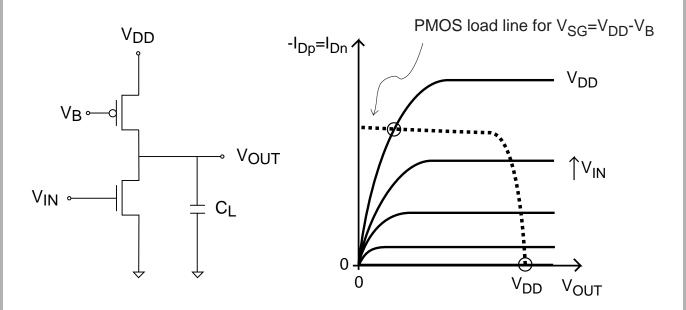
Note: enhancement-mode PMOS has $V_{Tp} < 0$.

In saturation:

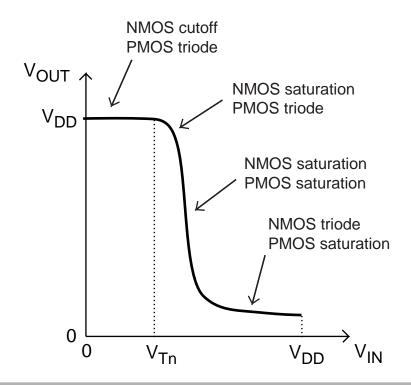
$$-\mathbf{I_{Dp}} \propto \left(\mathbf{V_{SG}} + \mathbf{V_{Tp}}\right)^{2}$$

PMOS as current-source pull-up:

Circuit and load-line diagram of inverter with PMOS current source pull-up:



Inverter characteristics:



PMOS as current-source pull-up:

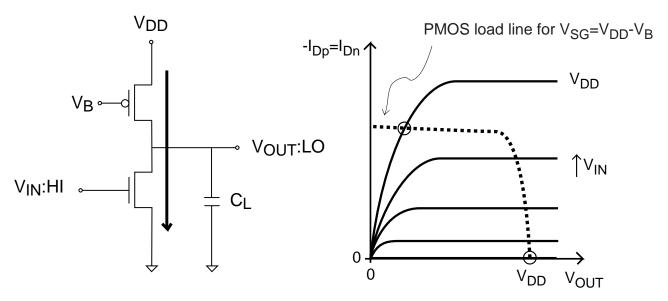
NMOS inverter with current-source pull-up allows high *noise margin* with *fast switching*

- High Incremental resistance
- Constant charging current of load capacitance

But...

When $V_{IN} = V_{DD}$, there is a direct current path between supply and ground

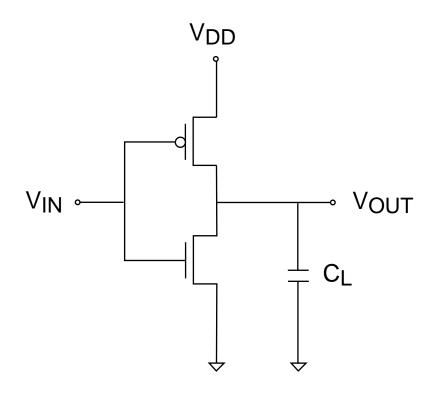
 \Rightarrow power is consumed even if the inverter is idle.



Ideally, we would like to have a current source that is *itself* switchable, i.e it shuts off when input is high $\Rightarrow CMOS!$

3. Complementary MOS (CMOS) Inverter

Circuit schematic:



Basic Operation:

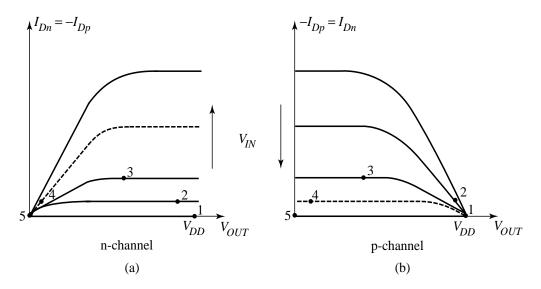
$$\begin{array}{cccc} \bullet & V_{IN} = 0 & \Rightarrow & V_{OUT} = V_{DD} \\ & V_{GSn} = 0 < V_{Tn} & \Rightarrow & \textbf{NMOS OFF} \\ & V_{SGp} = V_{DD} > - & V_{Tp} \Rightarrow & \textbf{PMOS ON} \end{array}$$

$$\begin{array}{cccc} \bullet & V_{IN} = V_{DD} & \Rightarrow & V_{OUT} = 0 \\ & V_{GSn} = V_{DD} > V_{Tn} & \Rightarrow & & \textbf{NMOS ON} \\ & V_{SGp} = 0 < - V_{Tp} & \Rightarrow & & \textbf{PMOS OFF} \end{array}$$

No power consumption while idle in any logic state!

CMOS Inverter (Contd.):

Output characteristics of both transistors:

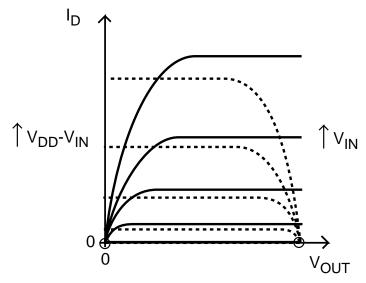


Note:

$$\begin{split} &V_{IN} = V_{GSn} = V_{DD} - V_{SGp} \implies V_{SGp} = V_{DD} - V_{IN} \\ &V_{OUT} = V_{DSn} = V_{DD} - V_{SDp} \implies V_{SDp} = V_{DD} - V_{OUT} \\ &I_{Dn} = -I_{Dp} \end{split}$$

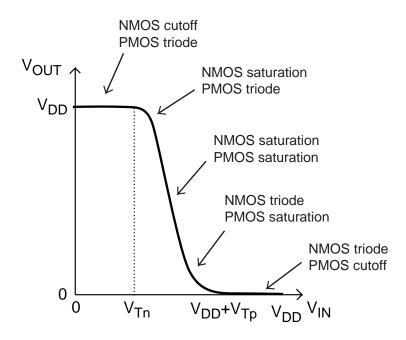
Combine into single diagram of I_D vs. V_{OUT} with V_{IN} as parameter

CMOS Inverter (Contd.):



• No current while idle in any logic state

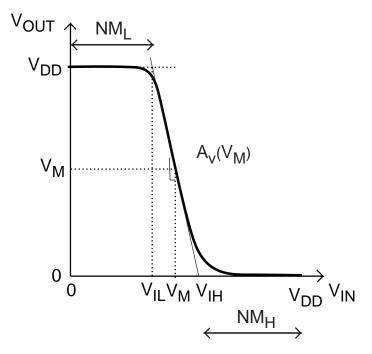
Inverter Characteristics:



- "rail-to-rail" logic: logic levels are 0 and V_{DD}
- High |A_v| around logic threshold

 \Rightarrow good noise margins

2. CMOS inverter: noise margins



- Calculate V_M
- Calculate $A_v(V_M)$
- Calculate NM_L and NM_H

Calculate $V_M (V_M = V_{IN} = V_{OUT})$

At V_M both transistors are saturated:

$$\mathbf{I_{Dn}} = \frac{\mathbf{W_n}}{2\mathbf{L_n}} \,\mu_{\mathbf{n}} \mathbf{C_{ox}} (\mathbf{V_M} - \mathbf{V_{Tn}})^2$$

$$-\mathbf{I_{Dp}} = \frac{\mathbf{W_p}}{2\mathbf{L_p}} \,\mu_{\mathbf{p}} \mathbf{C_{ox}} \left(\mathbf{V_{DD}} - \mathbf{V_M} + \mathbf{V_{Tp}} \right)^2$$

CMOS inverter: noise margins (contd.)

Define:

$$\mathbf{k_n} = \frac{\mathbf{W_n}}{\mathbf{L_n}} \mu_{\mathbf{n}} \mathbf{C_{ox}}; \qquad \mathbf{k_p} = \frac{\mathbf{W_p}}{\mathbf{L_p}} \mu_{\mathbf{p}} \mathbf{C_{ox}}$$

Since:

$$\mathbf{I_{Dn}} = -\mathbf{I_{Dp}}$$

Then:

$$\frac{1}{2}\mathbf{k_n}(\mathbf{V_M} - \mathbf{V_{Tn}})^2 = \frac{1}{2}\mathbf{k_p}(\mathbf{V_{DD}} - \mathbf{V_M} + \mathbf{V_{Tp}})^2$$

Solve for V_M :

$$V_{M} = \frac{V_{Tn} + \sqrt{\frac{k_{p}}{k_{n}}} \Big(V_{DD} + V_{Tp}\Big)}{1 + \sqrt{\frac{k_{p}}{k_{n}}}}$$

Usually, V_{Tn} and V_{Tp} fixed and $V_{Tn} = -V_{Tp}$ $\Rightarrow V_{M}$ engineered through k_{p}/k_{n} ratio.

CMOS inverter: noise margins (contd..)

• Symmetric case: $k_n = k_p$

$$\mathbf{V_M} = \frac{\mathbf{V_{DD}}}{2}$$

This implies:

$$\frac{\mathbf{k_p}}{\mathbf{k_n}} = 1 = \frac{\frac{\mathbf{W_p}}{\mathbf{L_p}} \mu_{\mathbf{p}} \mathbf{C_{ox}}}{\frac{\mathbf{W_p}}{\mathbf{L_n}} \mu_{\mathbf{n}} \mathbf{C_{ox}}} \approx \frac{\frac{\mathbf{W_p}}{\mathbf{L_p}} \mu_{\mathbf{p}}}{\frac{\mathbf{W_n}}{\mathbf{L_n}} 2\mu_{\mathbf{p}}} \Rightarrow \frac{\mathbf{W_p}}{\mathbf{L_p}} \approx 2 \frac{\mathbf{W_n}}{\mathbf{L_n}}$$

Since usually $L_p \approx L_n = L_{min} \Rightarrow W_p \approx 2W_n$

• Asymmetric case: $k_n >> k_p$, or $\frac{W_n}{L_n} >> \frac{W_p}{L_p}$

$$V_{\rm M} \approx V_{\rm Tn}$$

NMOS turns on as soon as V_{IN} goes above V_{Tn} .

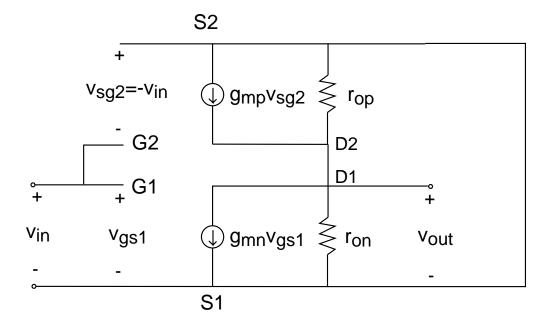
• Asymmetric case: $k_n << k_p,$ or $\frac{W_n}{L_n} << \frac{W_p}{L_p}$

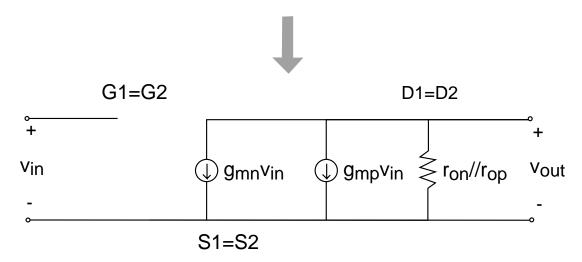
$$V_{M} \approx V_{DD} + V_{Tp}$$

PMOS turns on as soon as V_{IN} goes below $V_{DD} + V_{Tp}$.

CMOS inverter: noise margins (contd...) Calculate $A_v(V_M)$

• Small signal model:

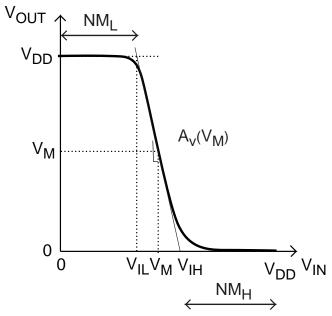




$$A_v = -\left(g_{mn} + g_{mp}\right)\left(r_{on} // r_{op}\right)$$

This can be rather large.

CMOS inverter: calculate noise margins (contd.)



• Noise-margin low, NM_L:

$$\begin{aligned} \mathbf{V_{IL}} &= \mathbf{V_{M}} - \frac{\mathbf{V_{DD}} - \mathbf{V_{M}}}{\left|\mathbf{A_{v}}\right|} \\ \mathbf{NM_{L}} &= \mathbf{V_{IL}} - \mathbf{V_{OL}} = \mathbf{V_{IL}} = \mathbf{V_{M}} - \frac{\mathbf{V_{DD}} - \mathbf{V_{M}}}{\left|\mathbf{A_{v}}\right|} \end{aligned}$$

• Noise-margin high, NM_H:

$$\mathbf{V_{IH}} = \mathbf{V_M} \left(1 + \frac{1}{|\mathbf{A_v}|} \right)$$

$$\mathbf{NM_H} = \mathbf{V_{OH}} - \mathbf{V_{IH}} = \mathbf{V_{DD}} - \mathbf{V_M} \left(1 + \frac{1}{|\mathbf{A_v}|} \right)$$

What did we learn today?

Summary of Key Concepts

- In NMOS inverter with resistor pull-up, there is a trade-off between noise margin and speed
- Trade-off resolved using current source pull-up
 - Use PMOS as current source.
- In NMOS inverter with current-source pull-up: if V_{IN} = High, there is power consumption even if inverter is idling.
- Complementary MOS: NMOS and PMOS switchon alternatively.
 - No current path between power supply and ground
 - No power consumption while idling
- Calculation of CMOS
 - $-V_{\rm M}$
 - Noise Margin